#### 查询54ACT16657供应商 捷多邦,专业PCB打样工**54AQ不16657**世登4ACT16657 16-BIT TRANSCEIVERS WITH PARITY GENERATORS/CHECKERS AND 3-STATE OUTPUTS SCAS164A – JANUARY 1991 – REVISED APRIL 1996

- Members of the Texas Instruments *Widebus*™ Family
- Inputs Are TTL-Voltage Compatible
- Flow-Through Architecture Optimizes PCB Layout
- Distributed V<sub>CC</sub> and GND Pin Configuration Minimizes High-Speed Switching Noise
- *EPIC*<sup>™</sup> (Enhanced-Performance Implanted CMOS) 1-μm Process
- 500-mA Typical Latch-Up Immunity at 125°C
- Package Options Include Plastic 300-mil Shrink Small-Outline (DL) Packages Using 25-mil Center-to-Center Pin Spacings and 380-mil Fine-Pitch Ceramic Flat (WD) Packages Using 25-mil Center-to-Center Pin Spacings

#### description

The 'ACT16657 contain two noninverting octal transceiver sections with separate parity generator/checker circuits and control signals. For either section, the transmit/receive (1T/ $\overline{R}$  or 2T/ $\overline{R}$ ) input determines the direction of data flow. When 1T/ $\overline{R}$  (or 2T/ $\overline{R}$ ) is high, data flows from the 1A (or 2A) port to the 1B (or 2B) port (transmit mode); when 1T/ $\overline{R}$  (or 2T/ $\overline{R}$ ) is low, data flows from the 1B (or 2B) port to the 1A (or 2A) port (receive mode). When the output-enable (1 $\overline{OE}$  or 2 $\overline{OE}$ ) input is high, both the 1A (or 2A) and 1B (or 2B) ports are in the high-impedance state.

Odd or even parity is selected by a logic high or low level, respectively, on the 1ODD/EVEN (or 2ODD/EVEN) input. 1PARITY (or 2PARITY) carries the parity bit value; it is an output from the parity generator/checker in the transmit mode and an input to the parity generator/checker in the receive mode.

54ACT16657 WD PACKAGE 74ACT16657 DL PACKAGE (TOP VIEW)										
10E NC 1ERR GND 1A1 1A2 V <sub>CC</sub> 1A3 1A4 1A5 GND 1A6 1A7 1A8 2A1 2A3 GND 2A4 2A3 GND 2A4 2A3 CND 2A4 2A3 CND 2A4 2A5 2A6 V <sub>CC</sub> 2A7 2A8 CND	(TOP V 1 2 3 4 5 6 7 8 9 10 11 12 13 14 15 16 17 18 19 20 21 22 23 24 25 26 27	56   55   54   53   52   51   50   49   48   47   46   45   44   43   42   41   40   39   38   37   36   334   337   36   334   332   311   300   301	1T/R   10DD/EVEN   1PARITY   GND   1B1   1B2   VCC   1B3   1B4   1B5   GND   1B8   2B1   2B2   2B3   GND   2B4   2B5   2B6   Vcc   2B7   2B8   GND   2PARITY   2ODD/EVEN							
20E	28	29	] 2T/R							

NC - No internal connection

In the transmit mode, after the 1A (or 2A) bus is polled to determine the number of high bits, 1PARITY (or 2PARITY) is set to the logic level that maintains the parity sense selected by the level at the 1ODD/EVEN (or 2ODD/EVEN) input. For example, if 1ODD/EVEN is low (even parity selected) and there are five high bits on the 1A bus, then 1PARITY is set to the logic high level so that an even number of the nine total bits (eight 1A-bus bits plus parity bit) are high.



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### description (continued)

In the receive mode, after the 1B (or 2B) bus is polled to determine the number of high bits, the  $1\overline{\text{ERR}}$  (or  $2\overline{\text{ERR}}$ ) output logic level indicates whether or not the data to be received exhibits the correct parity sense. For example, if  $10DD/\overline{\text{EVEN}}$  is high (odd parity selected), 1PARITY is high, and there are three high bits on the 1B bus, then  $1\overline{\text{ERR}}$  is low, indicating a parity error.

The 74ACT16657 is packaged in TI's shrink small-outline package, which provides twice the I/O pin count and functionality of standard small-outline packages in the same printed-circuit-board area.

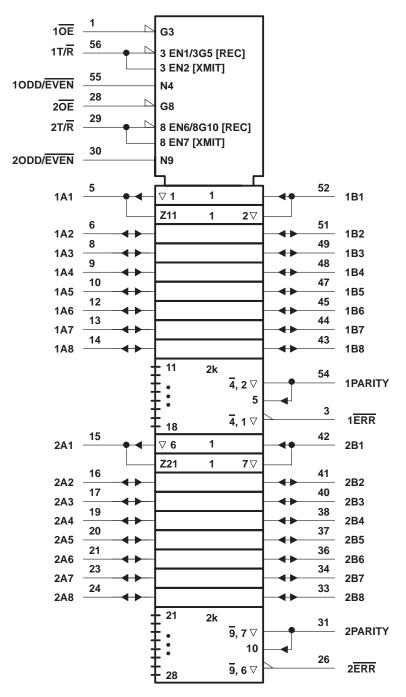
The 54ACT16657 is characterized for operation over the full military temperature range of  $-55^{\circ}$ C to  $125^{\circ}$ C. The 74ACT16657 is characterized for operation from  $-40^{\circ}$ C to  $85^{\circ}$ C.

NUMBER OF A OR B		INPU	JTS	INPUT/OUTPUT	OUTPUTS		
INPUTS THAT ARE HIGH	OE	T/R	ODD/EVEN	PARITY	ERR	OUTPUT MODE	
	L	Н	Н	Н	Z	Transmit	
	L	Н	L	L	Z	Transmit	
	L	L	н	н	н	Receive	
0, 2, 4, 6, 8	L	L	н	L   L		Receive	
	L	L	L	н	L	Receive	
	L	L	L	L	н	Receive	
	L	Н	Н	L	Z	Transmit	
	L	Н	L	н	Z	Transmit	
4 9 5 7	L	L	Н	н с		Receive	
1, 3, 5, 7	L	L	н	L	н	Receive	
	L	L	L	н	н	Receive	
	L	L	L	L	L	Receive	
Don't care	Н	Х	Х	Z	Z	Z	

FUNCTION TABLE



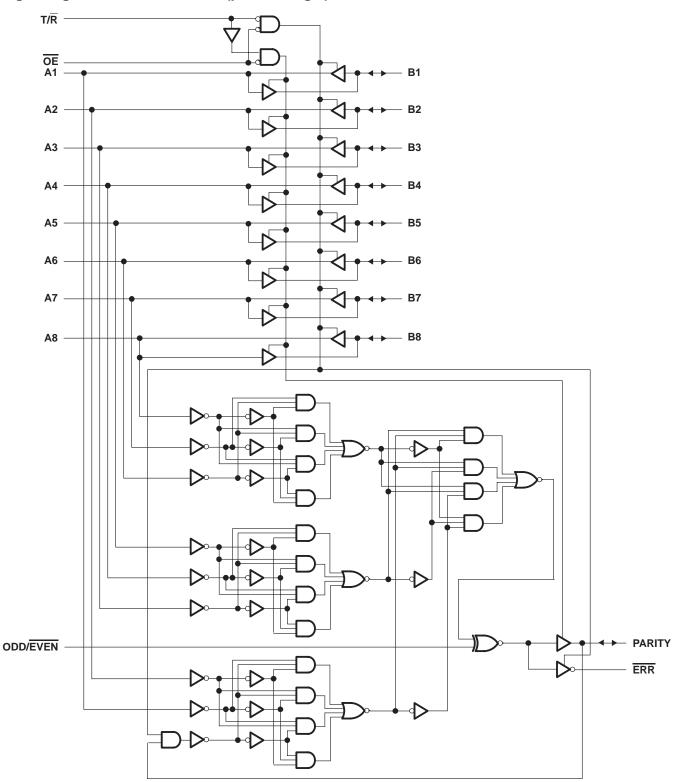
logic symbol<sup>†</sup>



<sup>†</sup> This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.



logic diagram, each transceiver (positive logic)





#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)<sup>†</sup>

Supply voltage range, V <sub>CC</sub>	–0.5 V to 7 V
Input voltage range, V <sub>I</sub> (see Note 1)–0.	5 V to V <sub>CC</sub> + 0.5 V
Output voltage range, V <sub>O</sub> (see Note 1)0.	5 V to V <sub>CC</sub> + 0.5 V
Input clamp current, I <sub>IK</sub> (V <sub>I</sub> < 0 or V <sub>I</sub> > V <sub>CC</sub> )	±20 mA
Output clamp current, $I_{OK}$ (V <sub>O</sub> < 0 or V <sub>O</sub> > V <sub>CC</sub> )	±50 mA
Continuous output current, $I_O (V_O = 0 \text{ to } V_{CC})$	±50 mA
Continuous current through V <sub>CC</sub> or GND	±500 mA
Maximum package power dissipation at $T_A = 55^{\circ}C$ (in still air) (see Note 2): DL package	1.4 W
Storage temperature range, T <sub>stg</sub>	–65°C to 150°C

<sup>†</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The maximum package power dissipation is calculated using a junction temperature of 150°C and a board trace length of 750 mils.

#### recommended operating conditions (see Note 3)

		54ACT16657			74ACT16657			UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.5	5	5.5	V
VIH	High-level input voltage	2		2			V	
VIL	Low-level input voltage		ng.	0.8			0.8	V
VI	Input voltage	0	A.	VCC	0		VCC	V
Vo	Output voltage	0	C'	VCC	0		VCC	V
ЮН	High-level output current	4	20	-24			-24	mA
IOL	Low-level output current	R	)	24			24	mA
$\Delta t/\Delta v$	Input transition rise or fall rate	0		10	0		10	ns/V
TA	Operating free-air temperature	-55		125	-40		85	°C

NOTE 3: Unused inputs must be held high or low to prevent them from floating.



electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	N	Т	<sub>Δ</sub> = 25°C	;	54ACT	16657	74ACT16657		UNIT	
		TEST CONDITIONS	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT	
			4.5 V	4.4			4.4		4.4			
		I <sub>OH</sub> = -50 μA	5.5 V	5.4			5.4		5.4			
VOH		1011 - 24 mA	4.5 V	3.94			3.8		3.8		V	
		I <sub>OH</sub> = -24 mA	5.5 V	4.94			4.8		4.8			
		I <sub>OH</sub> = -75 mA <sup>†</sup>	5.5 V				3.85		3.85		1	
		101 - 50 114	4.5 V			0.1		0.1		0.1	V	
	l <sub>OL</sub> = 50 μA		5.5 V			0.1		0,1		0.1		
V <sub>OL</sub>	1	4.5 V			0.36		0.44		0.44			
		$I_{OL} = 24 \text{ mA}$	5.5 V			0.36	4	0.44		0.44		
		$I_{OL} = 75 \text{ mA}^{\dagger}$	5.5 V				(C)	1.65		1.65		
lj –	A or B ports	$V_I = V_{CC}$ or GND	5.5 V			±0.1	200	±1		±1	μA	
loz‡	Control inputs	$V_{O} = V_{CC}$ or GND	5.5 V			±0.5	d'	±5		±5	μA	
ICC		$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	5.5 V			8		80		80	μA	
∆ICC§		One input at 3.4 V, Other inputs at V <sub>CC</sub> or GND	5.5 V			0.9		1		1	mA	
Ci	Control inputs	$V_I = V_{CC}$ or GND	5 V		4.5						pF	
Co	ERR	V <sub>O</sub> = V <sub>CC</sub> or GND	5 V		11						pF	
Cio	A or B ports	$V_{O} = V_{CC}$ or GND	5 V		12						pF	

<sup>†</sup> Not more than one output should be tested at a time, and the duration of the test should not exceed 10 ms.

<sup>‡</sup> For I/O ports, the parameter I<sub>OZ</sub> includes the input leakage current.

\$ This is the increase in supply current for each input that is at one of the specified TTL voltage levels rather than 0 V or V<sub>CC</sub>.

# switching characteristics over recommended operating free-air temperature range, $V_{CC}$ = 5 V $\pm$ 0.5 V (unless otherwise noted) (see Figure 1)

DADAMETED	FROM	то	Т	λ = 25°C	;	54ACT	16657	74ACT	16657	LINUT
PARAMETER	(INPUT)	(OUTPUT)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
<sup>t</sup> PLH	A or B	B or A	4.1	7.3	9.6	4.1	10.7	4.1	10.7	200
<sup>t</sup> PHL	AUB		3.2	6.8	9.8	3.2	10.6	3.2	10.6	ns
<sup>t</sup> PLH	A	PARITY	4	8.6	12.9	4	14.3	4	14.3	ns
<sup>t</sup> PHL		PARITI	4.3	9	13.1	4.3	14.3	4.3	14.3	
<sup>t</sup> PLH	ODD/EVEN	PARITY, ERR	3.7	8.3	12.3	3.7	13.7	3.7	13.7	ns
<sup>t</sup> PHL	ODD/EVEN		4.1	8.8	12.8	4.1	<b>X</b> 14.1	4.1	14.1	
<sup>t</sup> PLH	в	ERR	3.9	8.6	13	3.9	14.6	3.9	14.6	ns
<sup>t</sup> PHL	В	EKK	4.3	9	13.3	4.3	14.7	4.3	14.7	115
<sup>t</sup> PLH	PARITY	ERR	3.8	8.4	12.2	3.8	13.8	3.8	13.8	ns
<sup>t</sup> PHL	PARIT	ERR	4.1	8	12.8	<b>4</b> .1	14.2	4.1	14.2	115
<sup>t</sup> PZH			2.6	6.1	10.1	2.6	11.3	2.6	11.3	ns
<sup>t</sup> PZL	OE	A, B, PARITY, or ERR	3.2	7.2	11.7	3.2	13	3.2	13	115
<sup>t</sup> PHZ	OE		5.9	8.6	10.5	5.9	11.2	5.9	11.2	200
<sup>t</sup> PLZ		A, B, PARITY, or ERR	5.3	8	9.8	5.3	10.5	5.3	10.5	ns

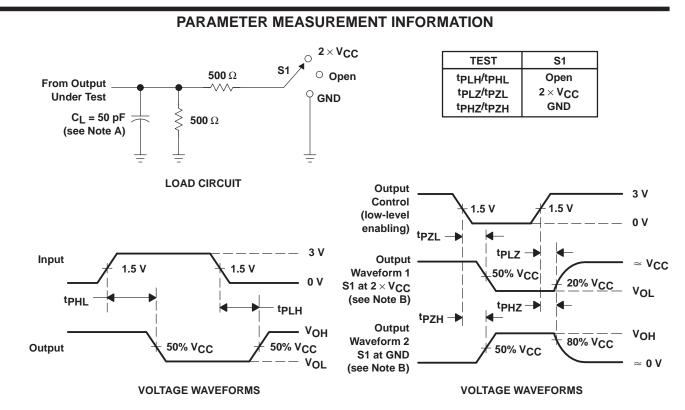


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SCAS164A - JANUARY 1991 - REVISED APRIL 1996

## operating characteristics, $V_{CC} = 5 V$ , $T_A = 25^{\circ}C$

PARAMETER				TEST CONDITIONS			
C <sub>pd</sub> Power dissipation capacitance per transceiver	Outputs enabled			76	ъE		
	Power dissipation capacitance per transceiver	Outputs disabled	C <sub>L</sub> = 50 pF, f = 1 MHz	35	pF		



- NOTES: A. CL includes probe and jig capacitance.
  - B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
  - C. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  1 MHz, Z<sub>O</sub> = 50  $\Omega$ , t<sub>f</sub> = 3 ns, t<sub>f</sub> = 3 ns.
  - D. The outputs are measured one at a time with one input transition per measurement.

#### Figure 1. Load Circuit and Voltage Waveforms



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